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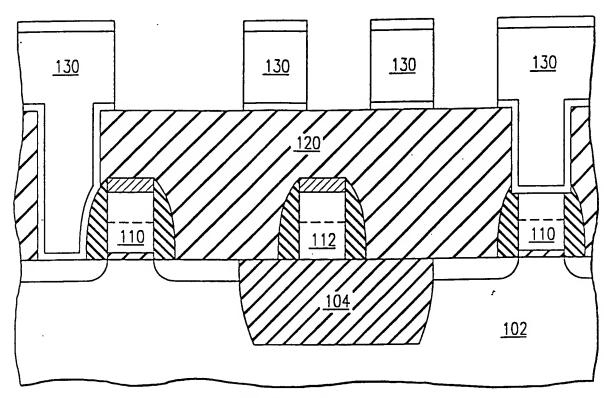


FIG. 1c

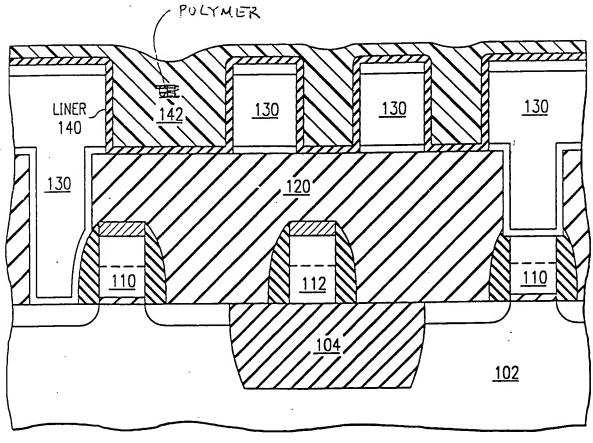


FIG. 1d

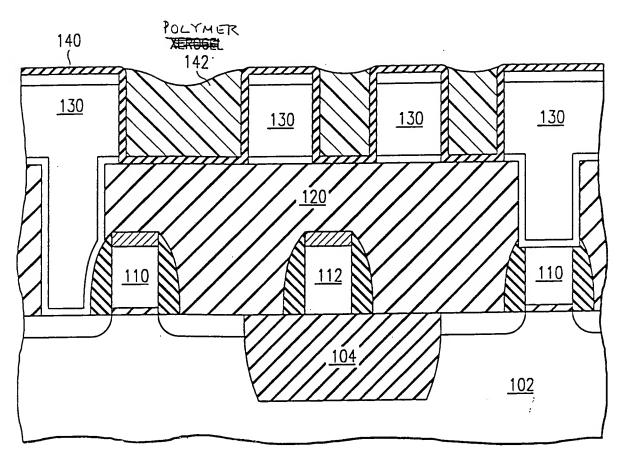


FIG. 1e

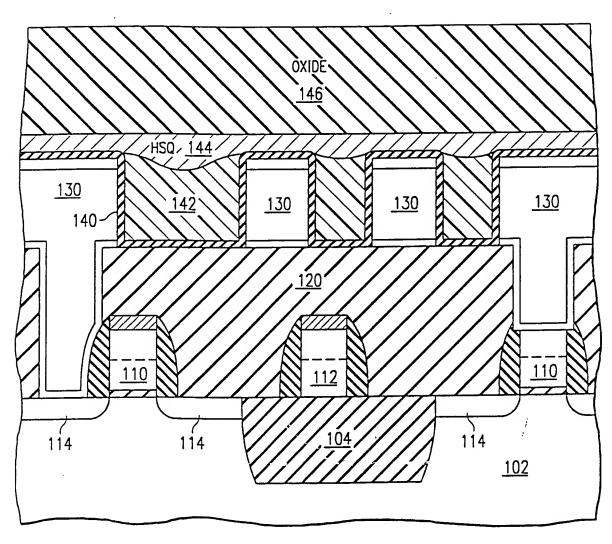


FIG. 1f

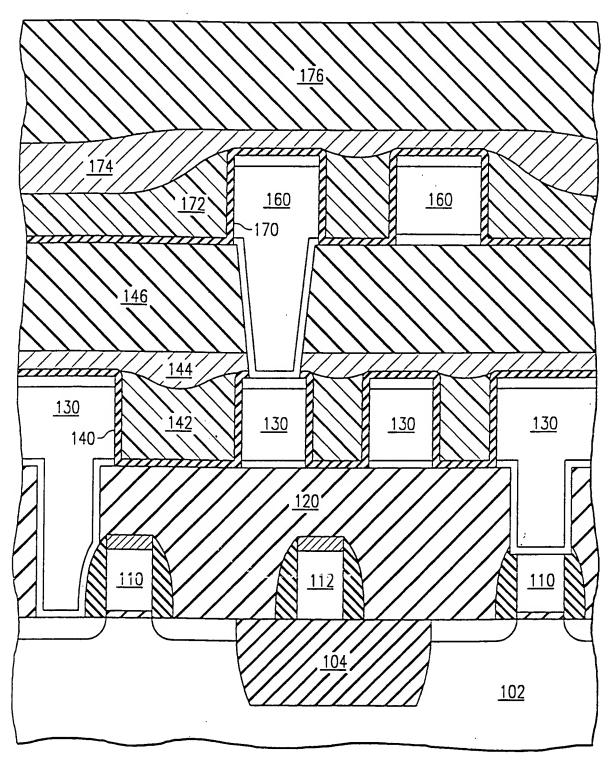


FIG. 1 g

 $V_{ij} = V_{ij} = V_{ij}$ 

: **=** .

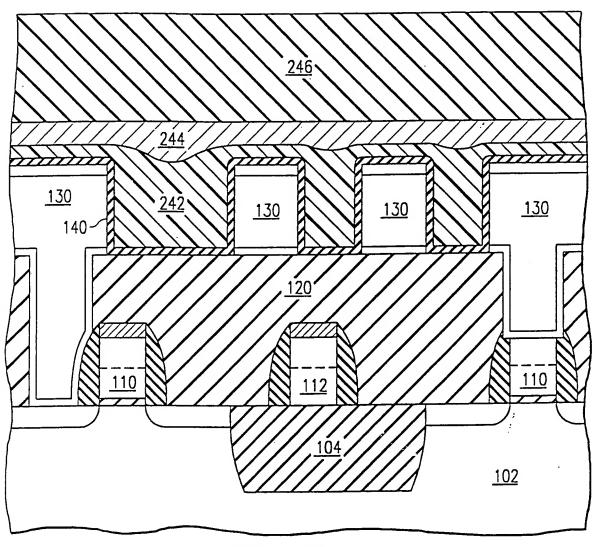


FIG. 2a

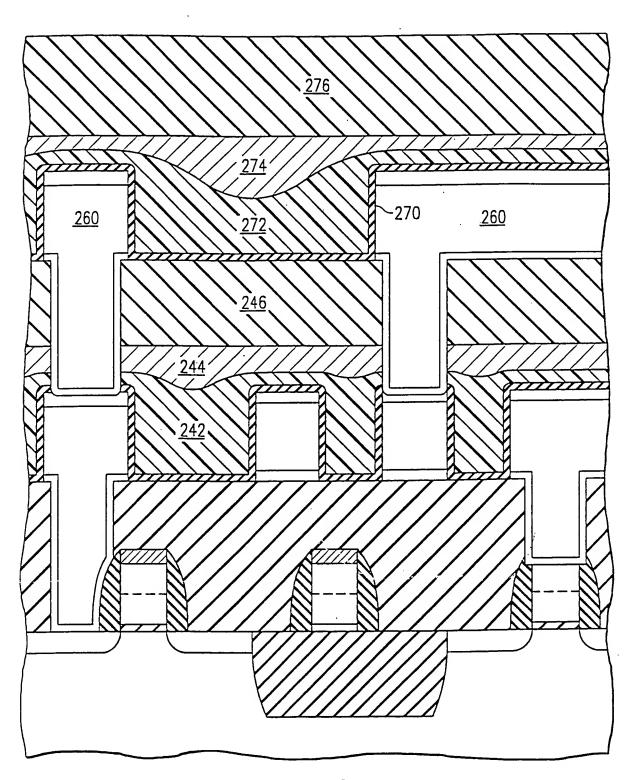


FIG. 2b

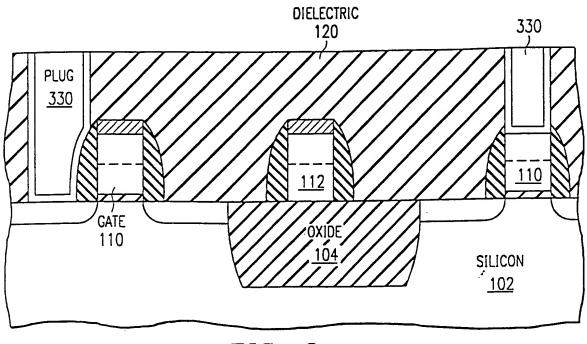


FIG. 3a

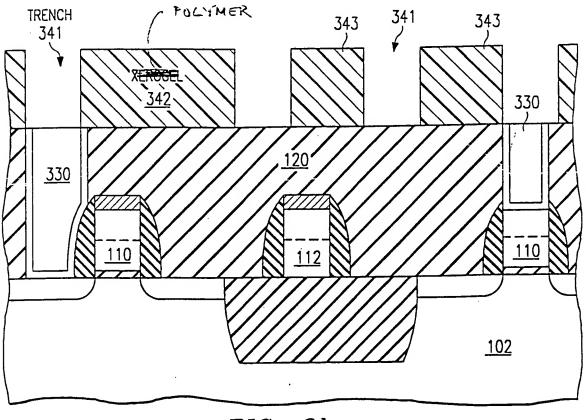


FIG. 3b

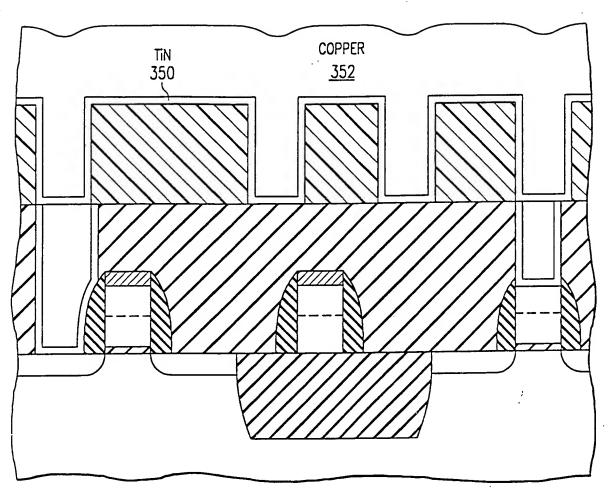


FIG. 3c

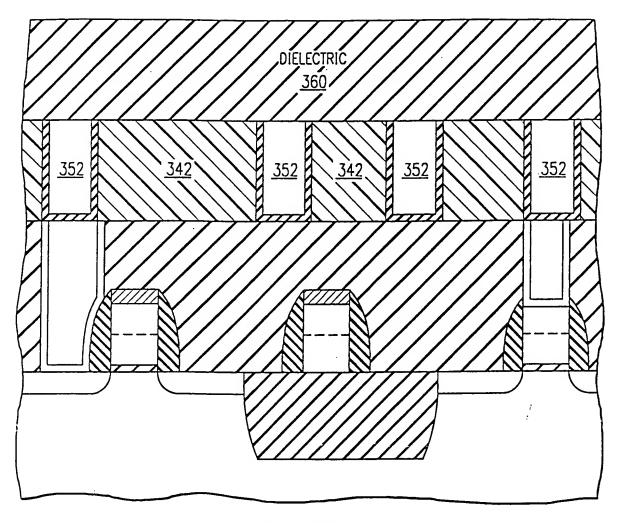


FIG. 3d

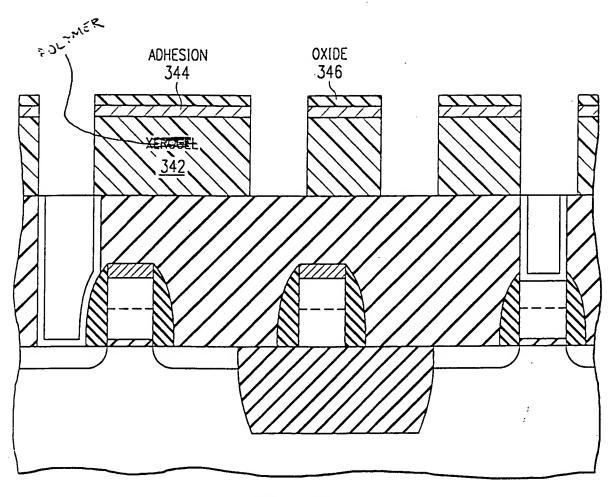


FIG. 3e

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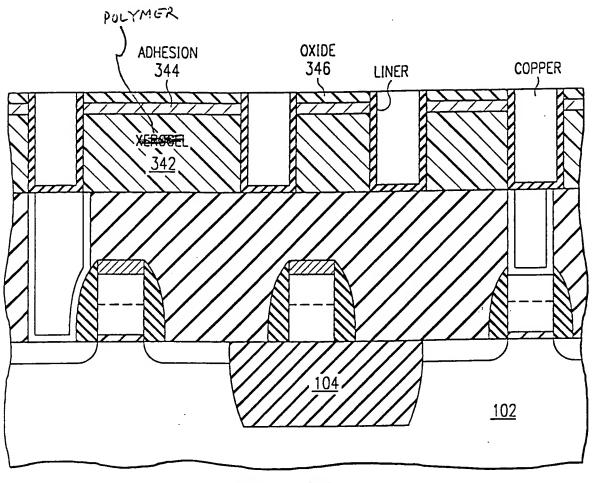
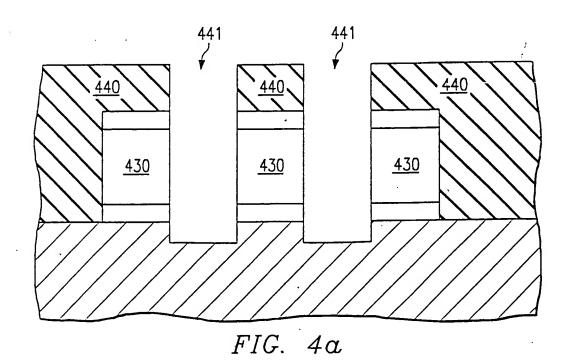
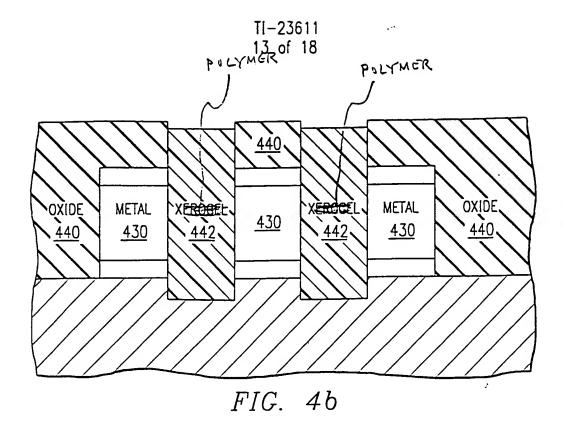


FIG. 3f





1 . . .

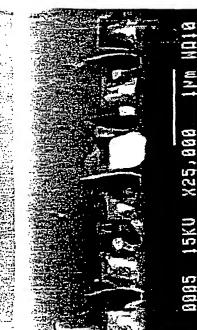
<u>470</u> <u>470</u> 0XIDE 460 430 442 440 <u>430</u> <u>430</u> FIG. 4c

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### PULSED PLASMA EFFECT TO GAP-FIL

50W deposition of Pentafluorophenyl-pentafluoro-1-propene, k~1.9.

1/5 ms on/off pulse



 $F_{ig} \lesssim 1/10$  ms on/off pulse



 $F_{ig}\,\mathcal{S}_{\mathcal{L}}$  1/20 ms on/off pulse



 $F_{g}$ , 5<sub>c</sub>1/30 ms on/off pulse

= 1/25 ms on/off pulse



Fig 5f 1/40 ms on/off pulse



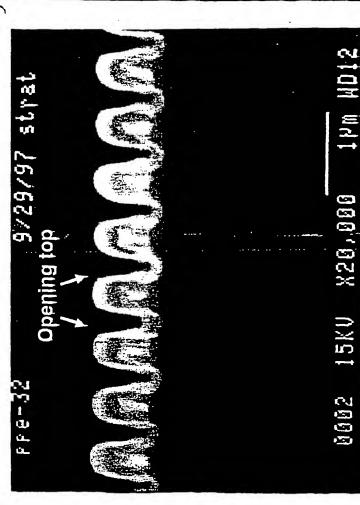


### PULSED PLASMA EFFECT TO GAP-FILL

Pentafluorophenyl-pentafluoro-1-propene

 $F_{ig}$  6  $\epsilon$ 

 $=\frac{50\text{W},\,1/10\,\,\text{ms on/off pulse}}{\sqrt[3]{6}\{\xi\}_{j}}$ 





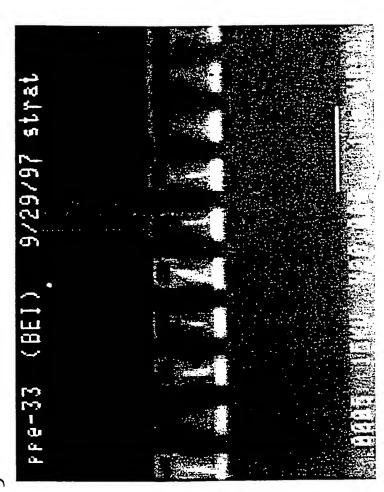
#### Semiconductor Process & Device Center

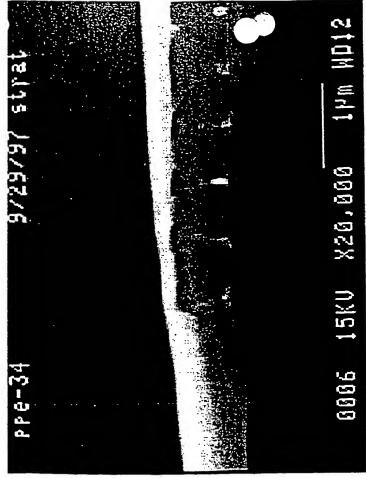
## SEM OF PULSED PLASMA DEPOSITION FOR GAP FILL

PPPE has dielectric constant value ~1.9.

 $_{Fig}$   $7_c$ Gap fill deposition: 50W, 1/40ms, 10min

 $\vec{\mathcal{F}}_{ij}$   $\mathcal{H}$  Planar deposition: 50W, 1/40ms, 20min



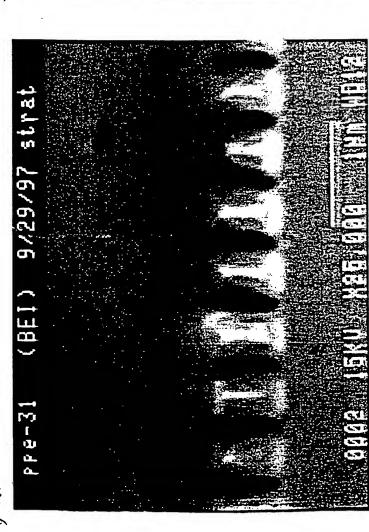




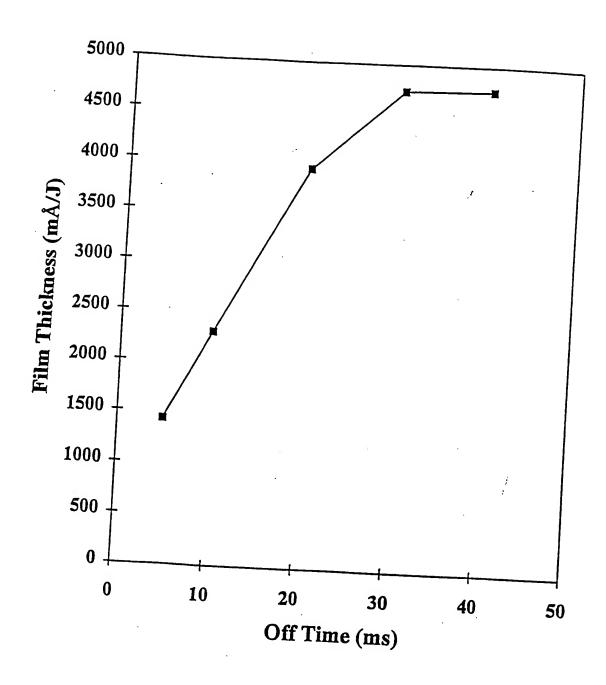
# EFFECT OF POWER TO PULSED PLASMA DEPOSITION

 $\mathfrak{f}_{ig}$   $\delta_{\mathcal{A}}$  200W, 1/40ms, 60min

Fug S. 50W, 1/40ms, 20min







Fig易9

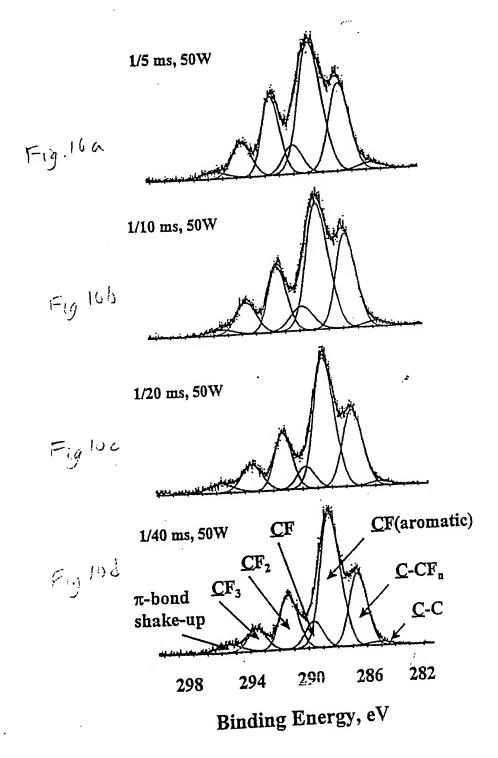
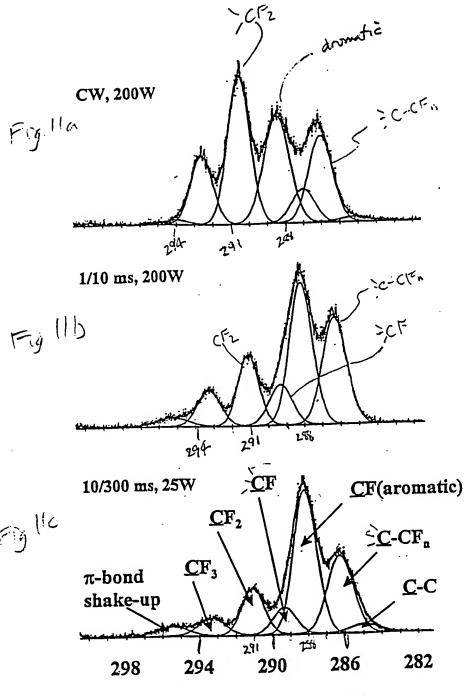


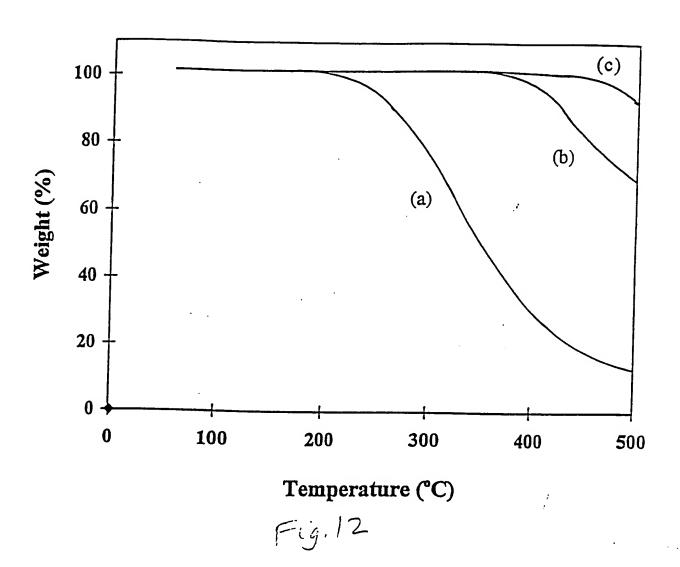
Fig.2

1. . . .

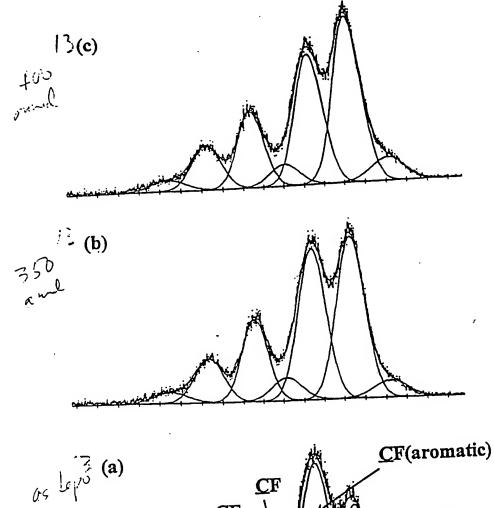


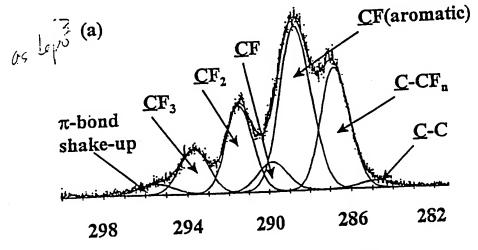
Binding Energy, eV

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F/8/6,



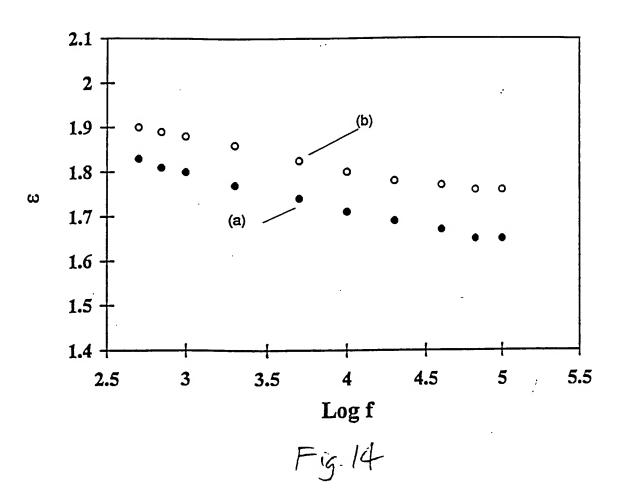


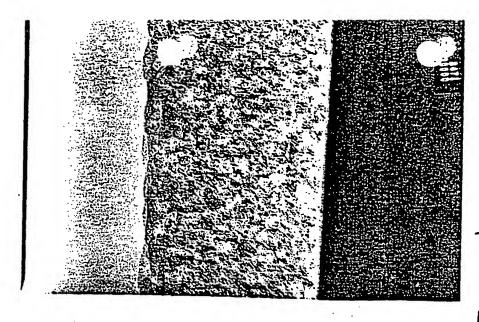
Binding Energy, eV

Fig. 13

FB-2

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1-ig. 15-b

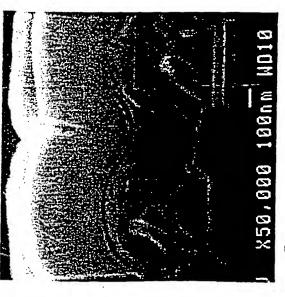


Fig. 15a